



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Basol Serial No.: 10/772,687 Filed: February 5, 2004 Title: PROCESS AND SYSTEM FOR PROVIDING ELECTROCHEMICAL PROCESSING SOLUTION WITH REDUCED OXYGEN AND GAS CONTENT	Group Art Unit: 1753 Examiner: Not yet assigned Docket: NT-319-US
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INFORMATION DISCLOSURE STATEMENT

US PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Publication Date	Name of Patentee or Applicant	
/EW/	AA	6,113,769	Sep., 2000	Uzoh et al.	In Serial No. 10/425,782

FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Publication Date	Name of Patentee or Applicant		

OTHER DOCUMENTS

Examiner Initials	Cite No.			Trans-lation
/EW/	AB	Victoria Shannon et al., "Copper Interconnects for High-Volume Manufacturing", Semiconductor International, May 2001	In Serial No. 10/425,782	

Examiner Signature	/Edna Wong/	Date Considered	10/02/2007
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PTO/SB/08 Equivalent

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Multiple sheets used when necessary)

SHEET 1 OF 1

Application No.	10/772,687
Filing Date	February 5, 2004
First Named Inventor	Basol
Art Unit	1753
Examiner	Edna Wong
Attorney Docket No.	ASMNUT.023CP1

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
/EW/	1	4,081,347	03-28-1978	Becker	
	2	5,383,483	01-1995	Shibano	
	3	5,695,545	12-1997	Cho et al.	
	4	5,762,684	06-1998	Hayashi et al.	
	5	5,788,742	08-1998	Sugimoto et al.	
	6	6,113,769	09-2000	Uzoh et al.	
	7	6,146,517	11-2000	Hoinkis	
	8	6,171,367 B1	01-2001	Peng et al.	
	9	6,328,785 B1	12-2001	Hayashi	
	10	6,328,871 B1	12-11-2001	Ding et al.	
	11	2001/052465 A1	12-20-2001	Dordi et al.	
	12	2004/0026255 A1	02-2004	Kovarsky et al.	
	13	2004/0060436 A1	04-2004	Parekh et al.	

FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T ¹
/EW/	14	DE 24 15 573 A	10-02-1975	Köhl		
	15	FR 2 416 958 A	09-07-1979	Bunker Ramo Corporation		
	16	EP 0 901 153 A2	03-10-1999	Kuriyama et al.		
	17	JP 61 012877 A	01-21-1986	Kobayashi		Abstract
	18	JP 2001-196728 A	07-19-2001	Tanaka		Abstract
	19	WO 00/75402 A1	12-14-2000	Stockbower		

NON PATENT LITERATURE DOCUMENTS

Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ¹

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Examiner Signature	/Edna Wong/	Date Considered	10/02/2007
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*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

T¹ - Place a check mark in this area when an English language Translation is attached.

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(Multiple sheets used when necessary)

SHEET 1 OF 1

Application No.	10/772,687
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/EW/	1	3,276,983 A	10-1966	Dolan et al.	
	2	3,616,599	11-02-1971	Burnham	
	3	6,110,345 A	08-2000	Iacoponi	
	4	6,241,585 B1	06-2001	White	
	5	6,254,760 B1	07-2001	Shen et al.	
	6	6,267,853 B1	07-2001	Dordi et al.	
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FOREIGN PATENT DOCUMENTS

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	14					
	15					
	16					
	17					
	18					
	19					

NON PATENT LITERATURE DOCUMENTS

Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ¹

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